

Silicon Carbide (SiC) **MOSFET** - 31 mohm, 650 V, M2, D2PAK-71 **NVBG045N065SC1**

Features

- Typ. $R_{DS(on)} = 31 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$ Typ. $R_{DS(on)} = 45 \text{ m}\Omega$ @ $V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge (Q_{G(tot)} = 105 nC)
- Low Effective Output Capacitance (Coss = 168 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

Typical Applications

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

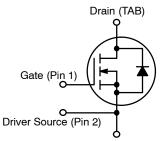
Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	650	V	
Gate-to-Source Voltage	ge		V _{GS}	-8/+22	V	
Recommended Operatives of Gate – Source \		T _C < 175°C	V_{GSop}	-5/+18	V	
Continuous Drain Current (Note 2)	Steady T _C = 25°C State		I _D	62	Α	
Power Dissipation (Note 2)			P _D	242	W	
Continuous Drain Current (Notes 1, 2)	Steady T _C = 100°C		I _D	44	Α	
Power Dissipation (Notes 1, 2)			P _D	121	W	
Pulsed Drain Current (Note 3) T _C = 25°C			I _{DM}	184	Α	
Single Pulse Surge Drain Current Capability	T_A = 25°C, t_p = 10 μ s, R_G = 4.7 Ω		I _{DSC}	315	Α	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)			I _S	56	Α	
Single Pulse Drain-to-Source Avalanche Energy (I _L = 12 A _{pk} , L = 1 mH) (Note 4)			E _{AS}	72	mJ	
Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds		TL	245	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on a FR-4 board using1 in² pad of 2 oz copper.

- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
650 V	50 m Ω @ 18 V	62 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

BG045N 065SC1 **AYWWZZ**

BG045N065SC1 = Specific Device Code

= Assembly Location Υ = Year

WW = Work Week = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NVBG045N065SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

4. E_{AS} of 72 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 12 A, V_{DD} = 50 V, V_{GS} = 18 V.

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-to-Case (Note 2)	$R_{ hetaJC}$	0.62	°C/W
Thermal Resistance Junction-to-Ambient (Notes 1, 2)	$R_{ hetaJA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1	mA	650			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 20 mA, refer	to 25°C		0.13		V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		V _{DS} = 650 V	T _J = 175°C			1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +18/-5 \text{ V}, \text{ V}$	/ _{DS} = 0 V			250	nA
ON CHARACTERISTICS	•	•					
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 8$	3 mA	1.8	2.8	4.3	V
Recommended Gate Voltage	V _{GOP}			-5		+18	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 15 V, I _D = 2	25 A, T _J = 25°C		45		mΩ
		V _{GS} = 18 V, I _D = 2	25 A, T _J = 25°C		31	50	
		V _{GS} = 18 V, I _D = 2	25 A, T _J = 175°C		40		1
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 2	25 A		16		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE	•			•		
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 325 V			1890		pF
Output Capacitance	C _{OSS}				168		
Reverse Transfer Capacitance	C _{RSS}				15		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/18 \text{ V}, V_{DS} = 520 \text{ V},$ $I_{D} = 25 \text{ A}$			105		nC
Gate-to-Source Charge	Q _{GS}				27		
Gate-to-Drain Charge	Q_{GD}				30		
Gate-Resistance	R _G	f = 1 MHz			3.1		Ω
SWITCHING CHARACTERISTICS	<u> </u>				I	ı	
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5/18 \text{ V}, V_{I}$			13		ns
Rise Time	t _r	$I_D = 25 A, R_G = 2$ Inductive Load	.2 Ω,		14		
Turn-Off Delay Time	t _{d(OFF)}	1			26		1
Fall Time	t _f	1			7		
Turn–On Switching Loss	E _{ON}	1			47		μJ
Turn-Off Switching Loss	E _{OFF}				33		1
Total Switching Loss	E _{TOT}				80		
DRAIN-SOURCE DIODE CHARACTERIS	1			•			
Continuous Drain-Source Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_{J} = 3$	25°C			56	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I _{SDM}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$				184	Α
Forward Diode Voltage	V _{SD}	V _{GS} = -5 V, I _{SD} = 25 A, T _J = 25°C			4.4		V

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)(continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTER	ISTICS	•				
Reverse Recovery Time	t _{RR}	V _{GS} = -5/18 V, I _{SD} = 25 A, dI _S /dt = 1000 A/μs		20		ns
Reverse Recovery Charge	Q _{RR}	- αι _S /αt = 1000 A/μs		100		nC
Reverse Recovery Energy	E _{REC}	1		3.8		μJ
Peak Reverse Recovery Current	I _{RRM}			10		Α
Charge Time	Ta	1		11		ns
Discharge Time	Tb	1		8.7		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

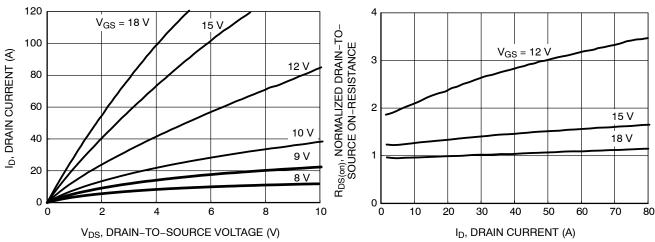


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

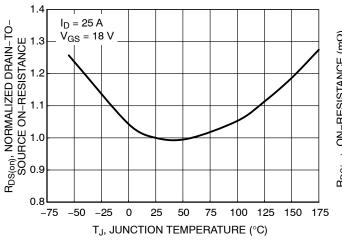


Figure 3. On–Resistance Variation with Temperature

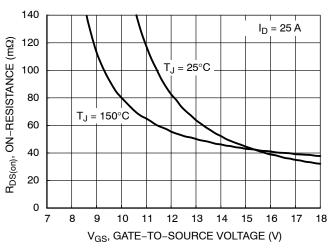


Figure 4. On-Resistance vs. Gate-to-Source Voltage

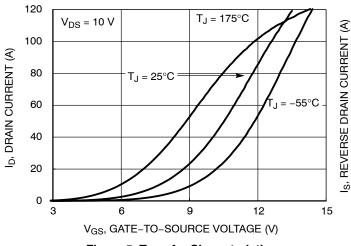


Figure 5. Transfer Characteristics

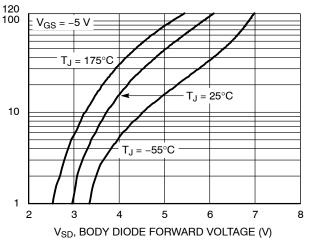


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS (continued)

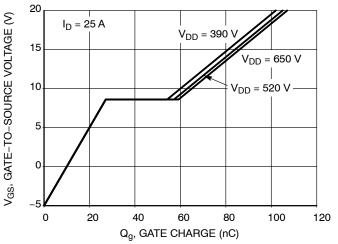


Figure 7. Gate-to-Source Voltage vs. Total Charge

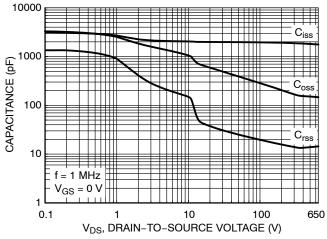


Figure 8. Capacitance vs. Drain-to-Source Voltage

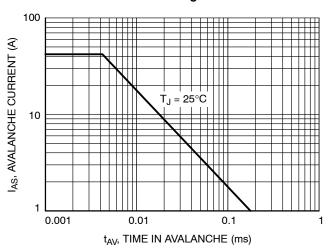


Figure 9. Unclamped Inductive Switching Capability

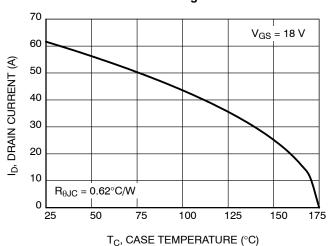


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

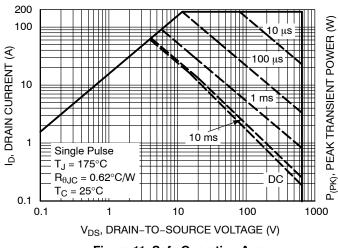


Figure 11. Safe Operating Area

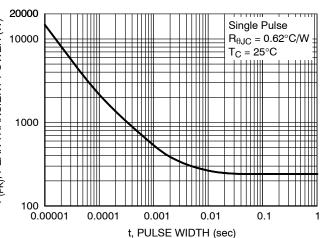


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

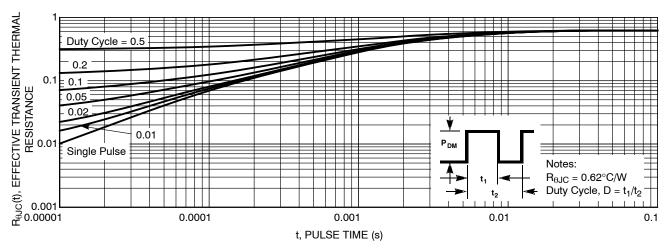


Figure 13. Junction-to-Case Transient Thermal Response

D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

DATE 16 AUG 2019

NOTES:

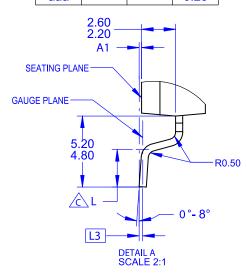
A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.

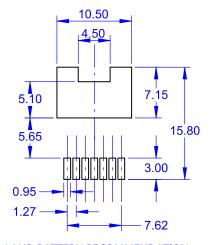
D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

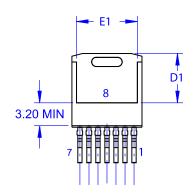
DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.30	4.50	4.70	
A1	0.00	0.10	0.20	
b2	0.60	0.70	0.80	
b	0.51	0.60	0.70	
С	0.40	0.50	0.60	
c2	1.20	1.30	1.40	
D	9.00	9.20	9.40	
D1	6.15	6.80	7.15	
Е	9.70	9.90	10.20	
E1	7.15	7.65	8.15	
е	~	1.27	~	
Н	15.10	15.40	15.70	
L	2.44	2.64	2.84	
L1	1.00	1.20	1.40	
L3	~	0.25	~	
aaa	~	~	0.25	

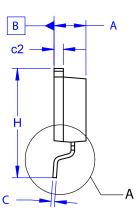


A	E L1
D	
<u> </u>	
b2 —	
e aaa B	b — A M



LAND PATTERN RECOMMENDATION





GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to

device data sneet for actual part marking.
Pb-Free indicator, "G" or microdot "■", may
or may not be present. Some products may
not follow the Generic Marking.

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